

MSN-C Structural Materials Beamline(s)

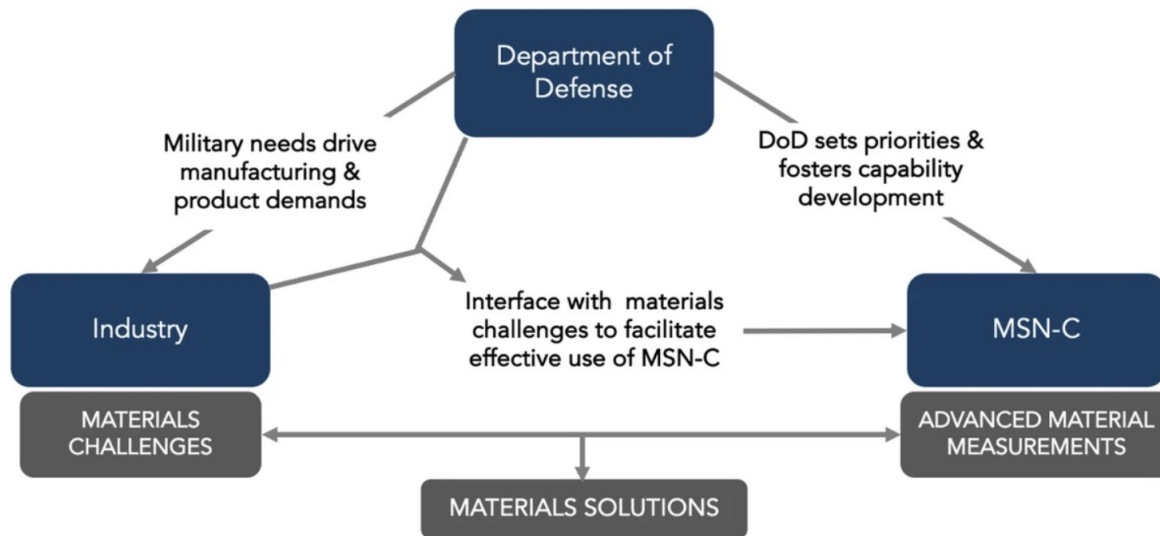
Kelly Nygren

Chris Budrow, Sven Gustafson, Amlan Das, Diwakar Naragani, Kate Shanks

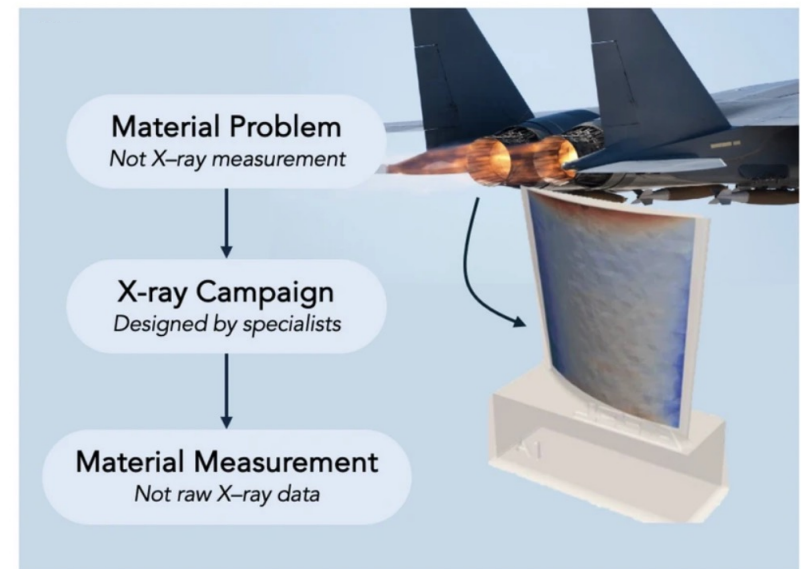
16 Aug 2026

Beamlines Provide Critical Measurements

MSN-C Mission: To advance critical materials solutions for *defense researchers and industry partners* through dedicated access to world-leading non-destructive measurements and analysis



DoD maximizes the application of techniques to a broad range of problems, facilitating **industry access on a per-measurement basis**



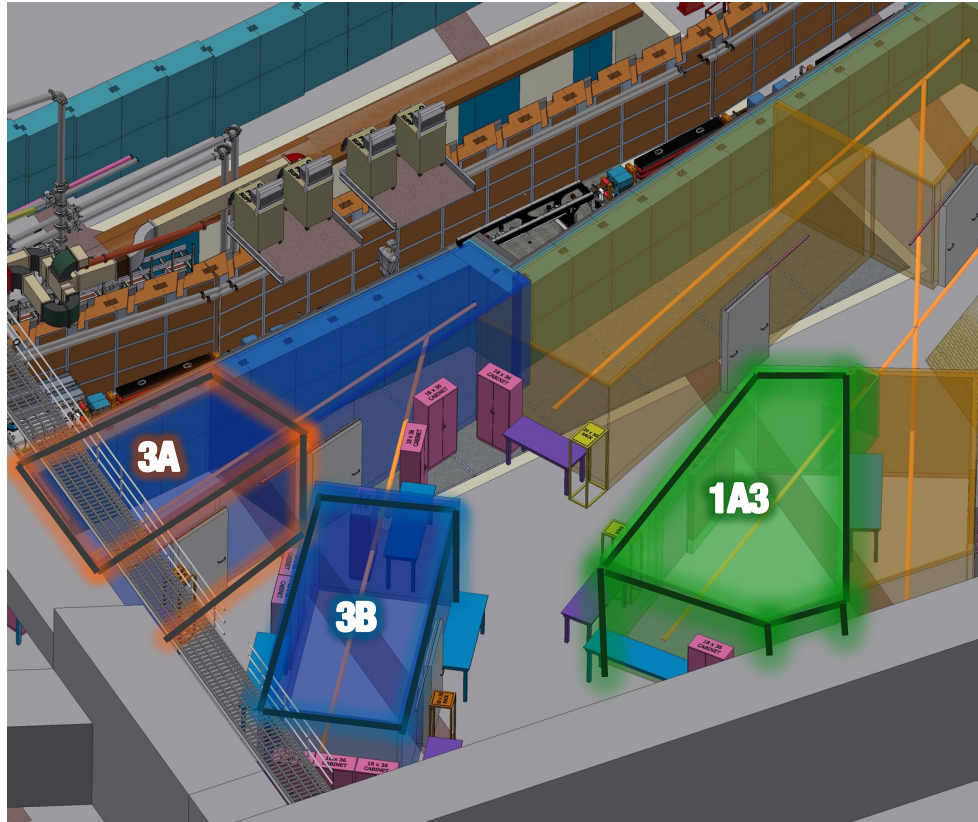
- ✓ Beamlines & Missions
- ✓ Standard Measurements
- ✓ Nuts and Bolts
- ✓ How we get it done

MSN-C Beamlines

All MSN-C beamlines optimized for X-ray **Imaging & Scattering**

Forming and Shaping Technologies (3A)
(structural materials)
(CHEXS)

Functional Materials Beamline (3B)
(MSN-C)



Structural Materials Beamline (1A3)
(MSN-C)

No hard rules on what science can happen at which beamline

Optimized for dense and less dense materials

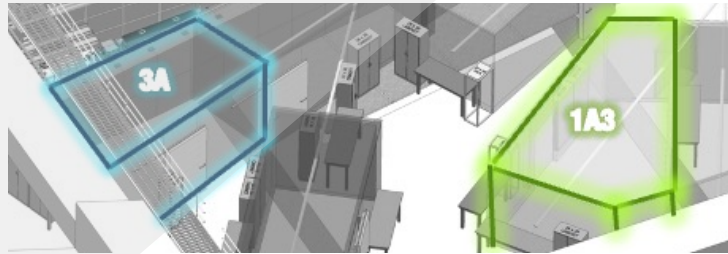
Ceramic composites fall in the middle of both capabilities

Two Structural Materials Beamlines

FAST Beamline Station 3A

Optimized for high-rate studies
with monochromatic beam

Beamlines honor a SWAP program to leverage each
program's specialized instrumentation



SMB Station 1A3

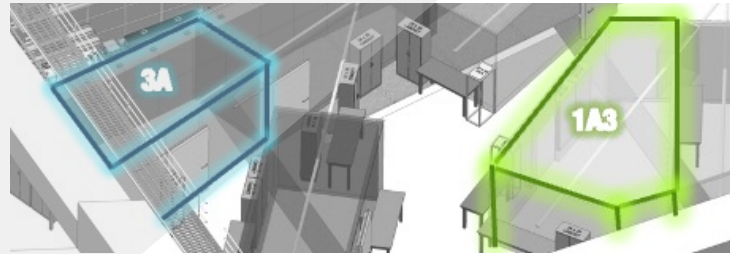
Optimized for dense materials
high energy and white beam

Complementary structural materials beamlines

Beamlines honor a SWAP program to leverage each program's specialized instrumentation

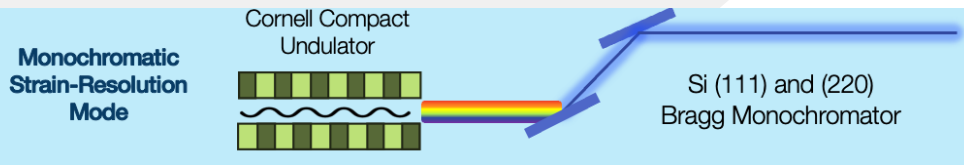
FAST Beamline Station 3A

Optimized for high-rate studies with monochromatic beam

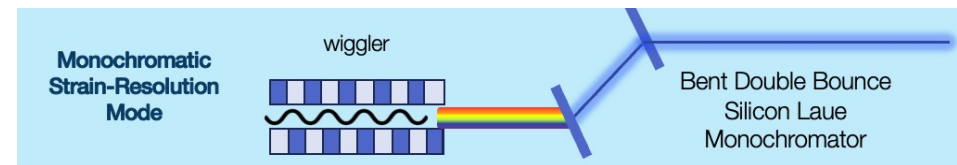


SMB Station 1A3

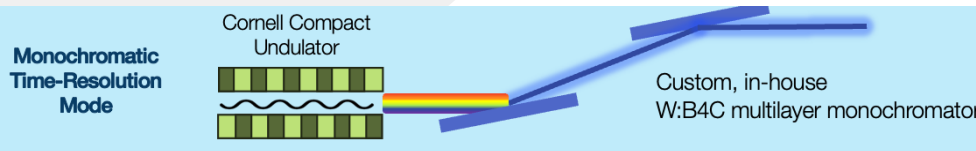
Optimized for dense materials high energy and white beam



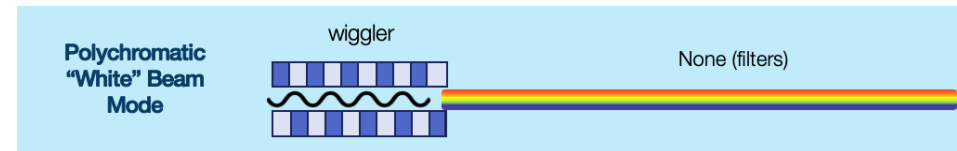
- 111 crystal set (20 - 42 keV) • Bandwidth: $\Delta E/E = 2 \times 10^{-3}$
- 220 crystal set (40 - 70 keV) • Bandwidth: $\Delta E/E = 6 \times 10^{-4}$



- Energy Range (40 - 90 keV) • Bandwidth: $\Delta E/E < 4 \times 10^{-3}$



- 10-30x increase in flux compared to DCM • Bandwidth: $\Delta E/E = 2.9 \times 10^{-2}$ (30 keV), 5×10^{-3} (60 keV)



Continuous Wiggler spectrum from 50-200keV

No focusing optics - beam size defined by slitting

| Beam Size | Biggest (w x h) | Smallest (w x h) |
|---------------|-----------------|-------------------------|
| Monochromatic | 2 mm x 1 mm | 20 μ m x 20 μ m |
| White Beam | 20 mm x 2 mm | 5 μ m x 5 μ m |

Complementary structural materials beamline programs

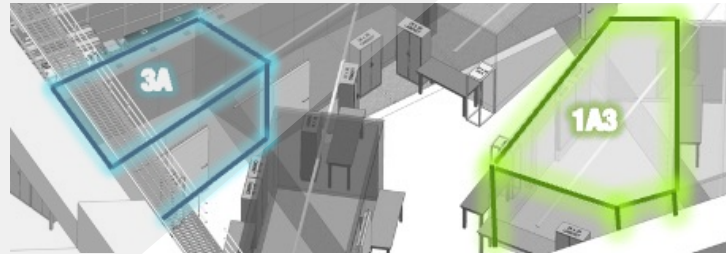


FAST Program CHEXS NSF-funded

Developing Techniques, Encouraging
Discovery and Exploration
Emphasis on novel problems

High Rate + Material Processing
Open User Program

Beamlines honor a SWAP program to leverage each
program's specialized instrumentation



SMB Program MSN-C DoD-funded

Maturing Techniques, Developing
Standards, Automation
Emphasis on applied problems

Material Performance & Residual Stress
Closed User Program

SMB Mission:

- Transform X-ray techniques from academic capabilities to engineering tools
Development of standards, automation and mature workflows
- Prioritize maturation of select techniques over measurements that are unique / first-of-a-kind
- Prioritize applied measurements that address a defense problem over measurements that lead to a scholarly publication

Explicitly cater to materials/mechanical domain experts with the assumption they will NOT become X-ray experts

The Structural Materials Community

Structural materials can sustain a load or withstand impact

Primary focus to date has been *engineering alloys*
some coatings, ceramic composites, CMCs

①

**Materials and processing
we already use**

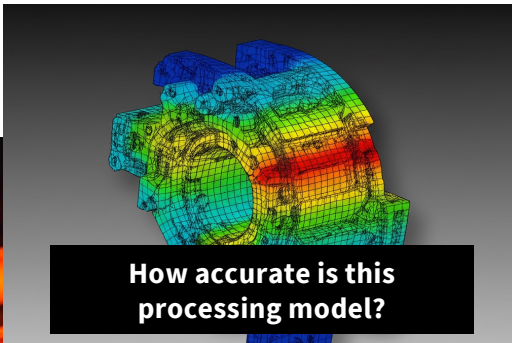
Current understanding allows for
managing use of
these materials and processes



②

**Materials and processing
we need to design**

Current understanding allows for
trial and error to design
these materials and processes



③

**New Alloying Strategies and
Advanced manufacturing
techniques**



④

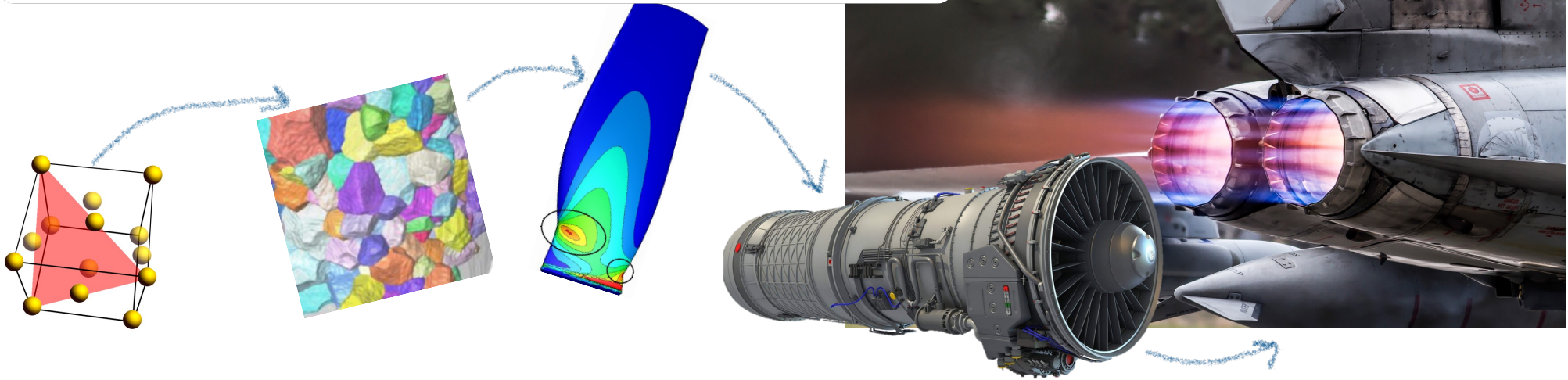
**Parts sometimes fail
in service**



Measurements required at critical length scales
within parts, to understand what's happening inside
the material—at **relevant times** during **processing,**
manufacturing, or **service conditions.**

Synchrotron X-rays are an invaluable probe for structural materials

Crystalline structure enables **diffraction-based techniques**—
directly probing **atomic arrangements across length scales**



Synchrotron X-rays are a *non-destructive* probe
that can **resolve the micromechanical and
microstructural state of crystalline solids**
(phase, orientation, or strain mapping)

Engineering alloys are **dense**
and require **high-energy X-rays**
for penetration

*SMB's "white beam" can
penetrate 40 mm of steel*

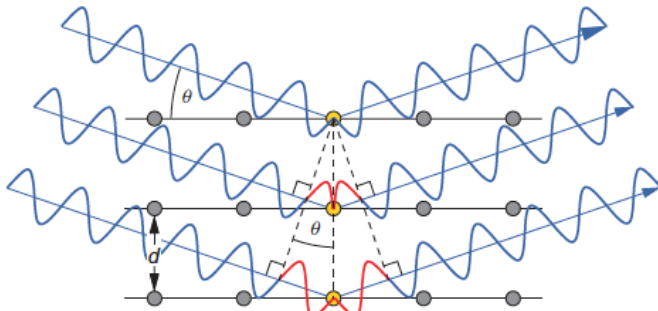
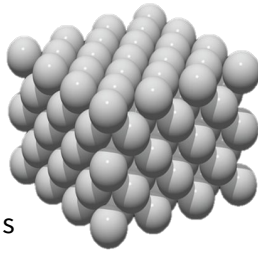
Microstructure of the material dictates its behavior... it also **dictates the accessible techniques**

Transmission Diffraction Techniques

Braggs Law

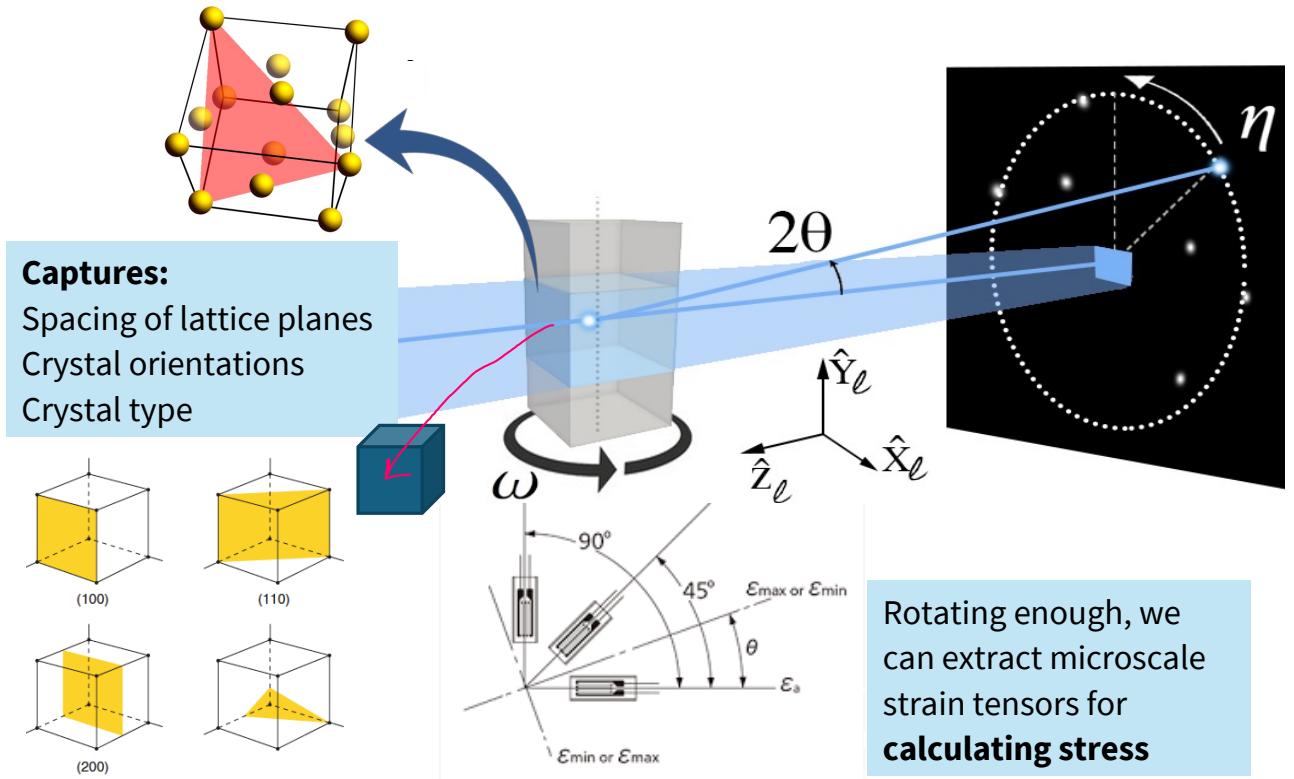
$$n\lambda = 2d\sin\theta$$

λ = wavelength of light
 d = spacing of planes of atoms
 θ = diffraction angle

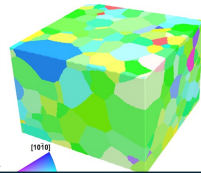


Utilize Large-Format Area Detectors

- > 1 ft x 1 ft area
- 18 million pixels

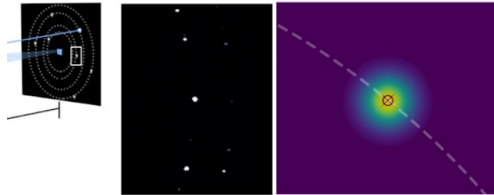


Microstructure and diffraction volume dictate the information we can extract



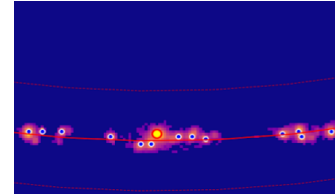
Isolated Peaks

Monochromatic
discrete energies
18 – 90 keV



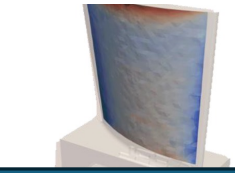
Crystal-differentiated
micromechanical and
microstructural state

Overlapping Peaks

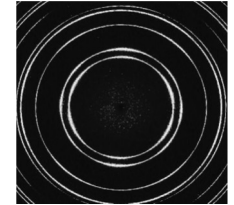


Region-averaged
phase and
orientation state

Area of active
investment

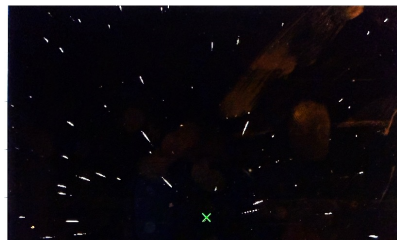


Contiguous Diffraction Rings

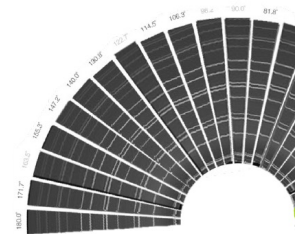


Region-averaged
micromechanical and
microstructural state

Polychromatic
White Beam
Continuous Spectrum
50-200 keV



Crystal-differentiated
microstructural state



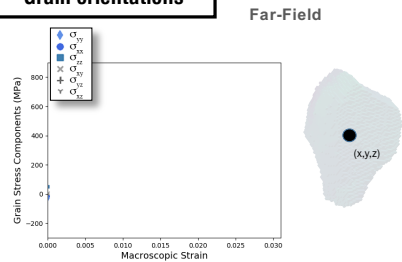
Region-averaged
micromechanical and
microstructural state

Workhorse Techniques/Capabilities

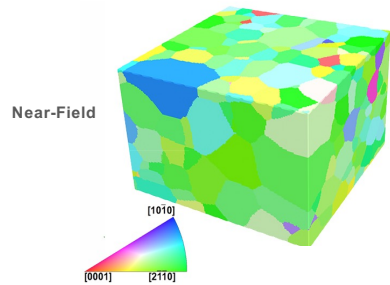
Monochromatic Techniques

High Energy X-ray Diffraction Microscopy

PROVIDES:
Grain centroid
Grain strain tensor
Grain orientations

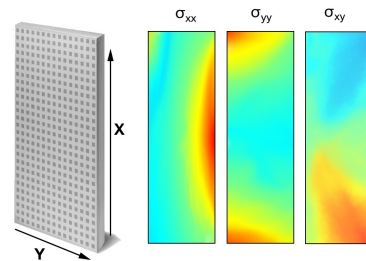


PROVIDES:
Spatial orientation maps of grains
Grain morphology

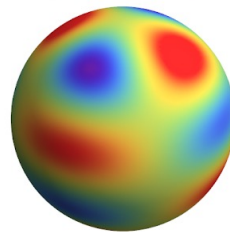


Angular Dispersive X-ray Diffraction

PROVIDES:
1D, 2D stress/strain distributions

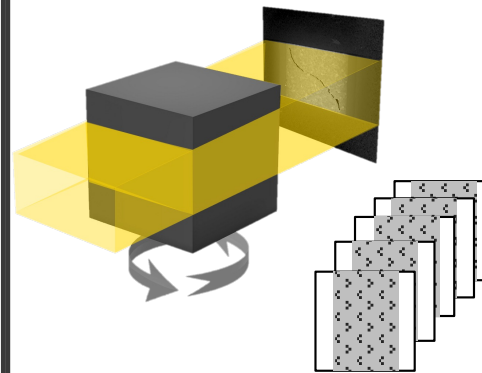


PROVIDES:
Texture pole figures
Strain pole figures



Absorption Tomography

PROVIDES:
Variation of porosity/cracks
Variations in phase

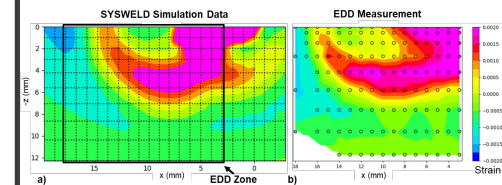
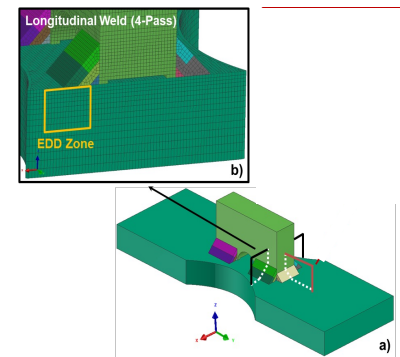


Sample is rotated 180° and a series of projection images are obtained

Polychromatic Technique

Energy Dispersive X-ray Diffraction

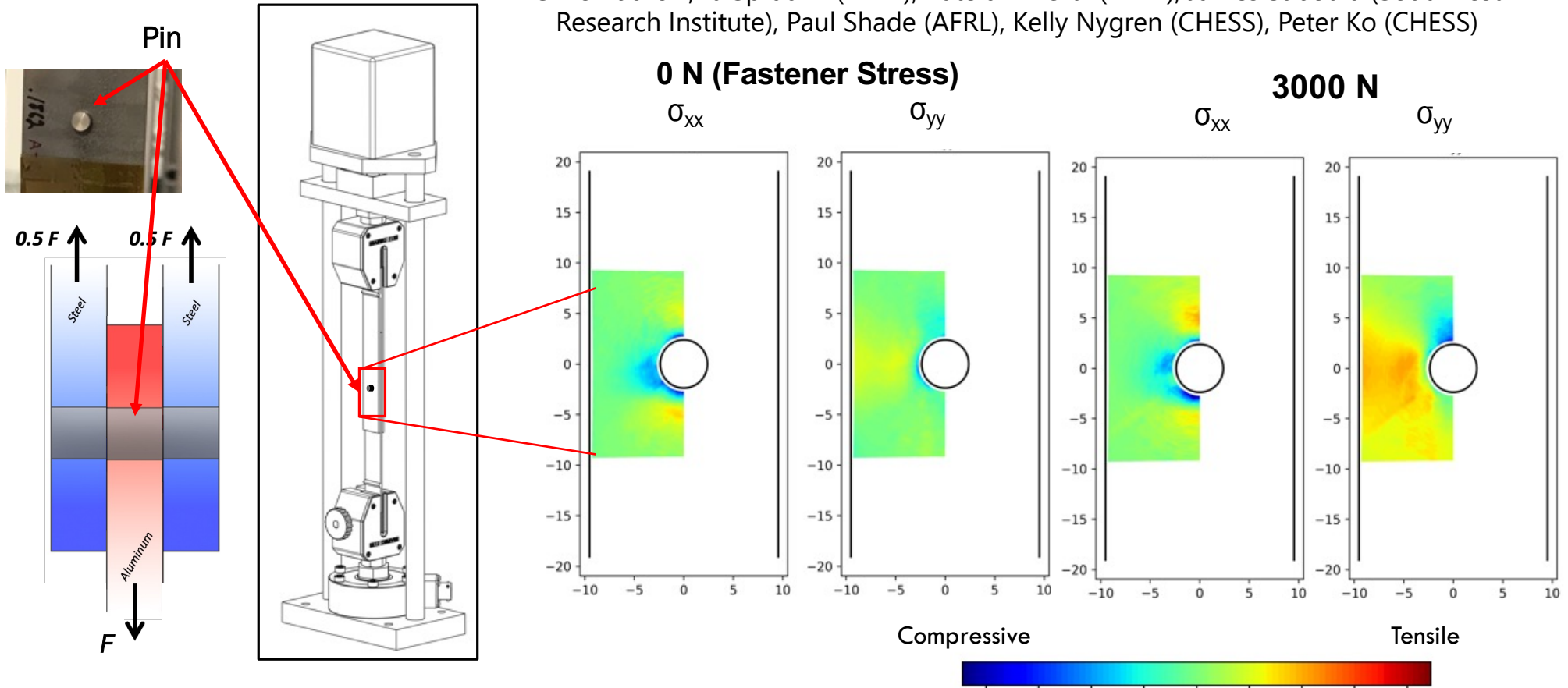
PROVIDES:
High-throughput, spatially-resolved distributions of strain / texture in large volumes (cm)



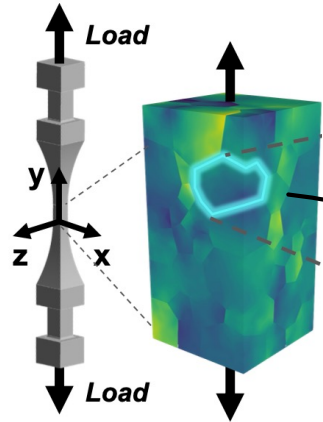
SMB Highlight: Residual Stress Caused by an Interference Fit Fastener

How does stress transfer from the pin to the **Aluminum** sample?

Chris Budrow, TJ Spradlin (AFRL), Katelun Wertz (AFRL), James Sabotka (Southwest Research Institute), Paul Shade (AFRL), Kelly Nygren (CHESS), Peter Ko (CHESS)

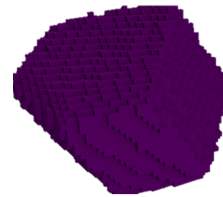


In Situ Mechanical Testing with RAMSIV

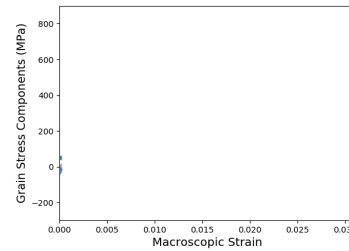


Capture grain-scale micromechanical state and microstructural character for **each crystal in the volume simultaneously**

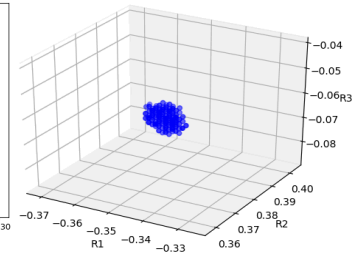
Grain Morphology Initial



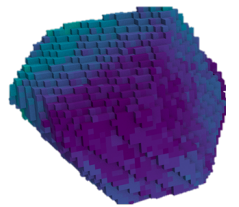
Micro-Mechanical Evolution



Orientation Evolution



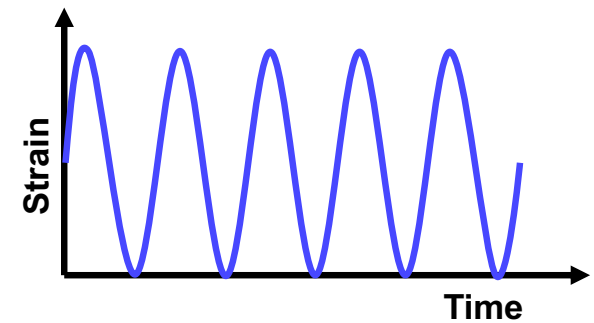
Grain Morphology Final



Avg. Data collection time for rotation series:

- Previously 6 min
- Currently <30 sec

Recent Advancement:
Strain-Controlled
High Cycle Fatigue



SMB's approach to industrial readiness

The synchrotron is an academic's land

Meeting Industrial Needs:

- ✓ Measure complex parts - not expect to tailor the microstructure/part for the measurement
- ✓ Mature techniques so they are reproducible engineering measurements with error bars
- ✓ Develop instrumentation so industry can come on a measurement-by-measurement basis
- ✓ Protect IP and export-controlled data, in addition to no publishing requirement
- ✓ Interface with 3D part and materials models directly
- ✓ Return final dataset as soon as possible after measurement – Ideally 1 week

Measurements that historically took 6 months to year+ to fully reduce...



AFRL sets priority and allocation policies

Industry Menu Items Prioritized two, high-demand workhorse techniques for industrial readiness

Of critical value to industry, synchrotrons offer **one of the only ways to measure strain deep inside intact parts**—enabling engineers to calculate stress, detect hidden weak spots, and extend the life of critical components

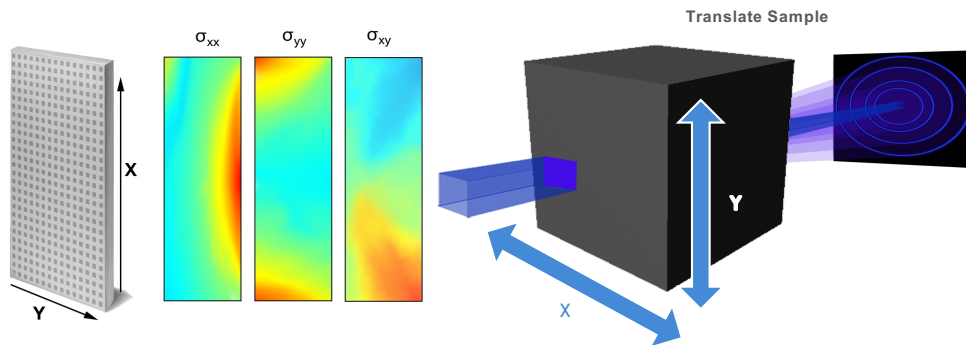
Angular Dispersive X-ray Diffraction (ADXRD) “Powder Diffraction” Technique

Monochromatic technique (40-90keV)

PROVIDES: 1D, 2D strain/orientation distributions

$$\lambda = 2d \sin \theta$$

↑ Set ↑ Solve ↑ Measure



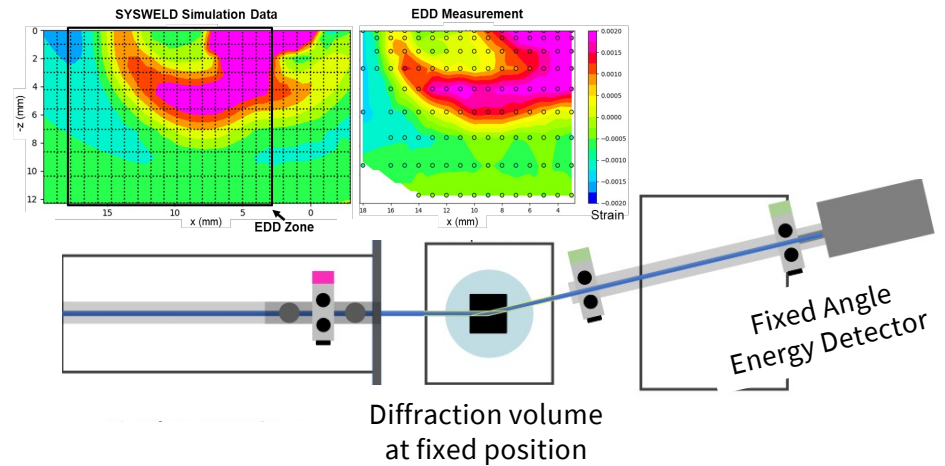
Energy Dispersive X-ray Diffraction (EDXRD)

Polychromatic technique (50-200keV)

PROVIDES: High-throughput, 3D distributions of strain / texture in large volumes (cm)

$$\lambda = \frac{hc}{E} = 2d \sin \theta$$

↑ Measure ↑ Solve ↑ Set

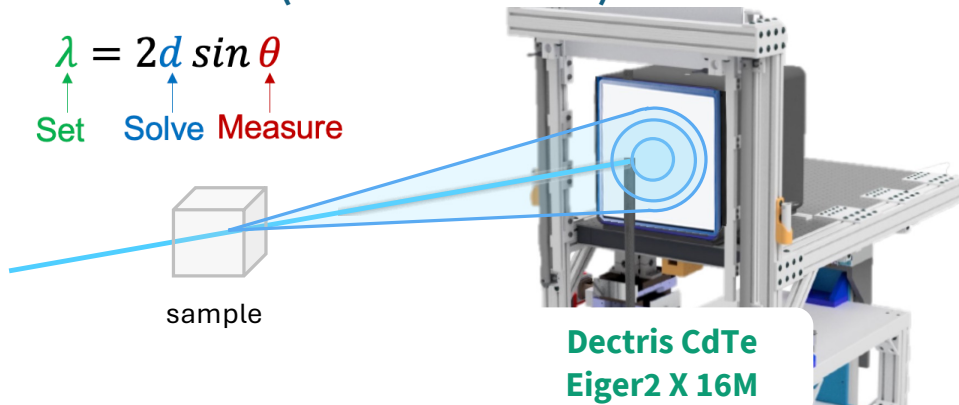


Measurement Needs Required State of the Art Detector Systems

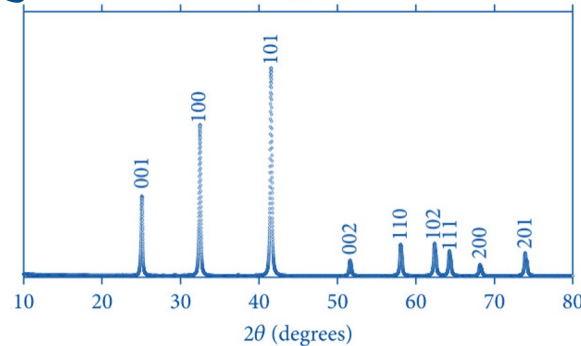
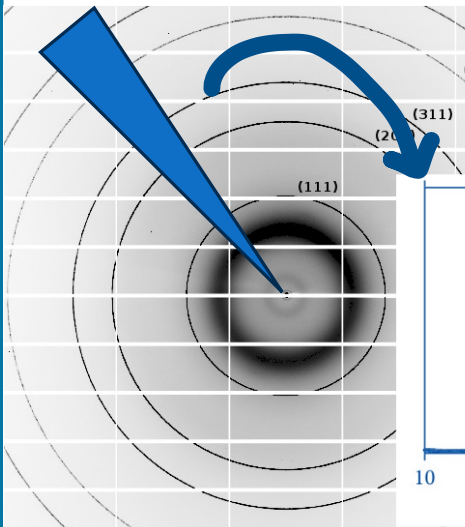
Monochromatic (discrete 40-90keV)

$$\lambda = 2d \sin \theta$$

↑ Set ↑ Solve ↑ Measure



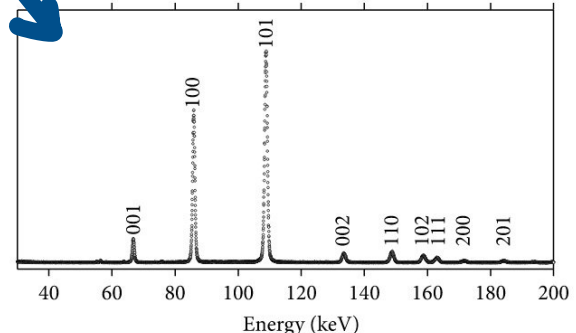
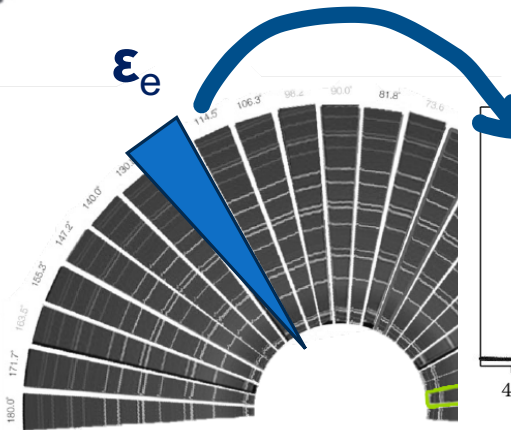
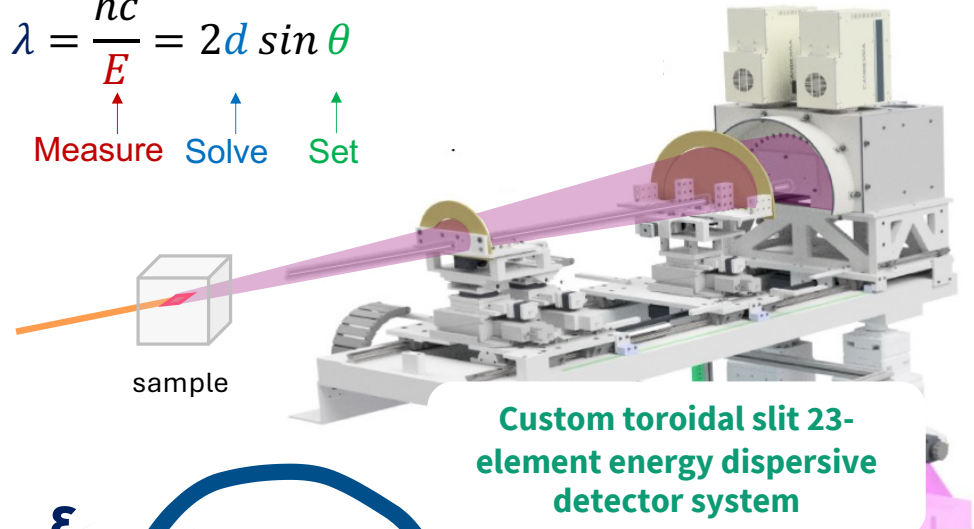
Frame Rate: 200 Hz
 Count Rate: 10^7 ph/sec/pix



Polychromatic "white beam" (continuous 50-200 keV)

$$\lambda = \frac{hc}{E} = 2d \sin \theta$$

↑ Measure ↑ Solve ↑ Set



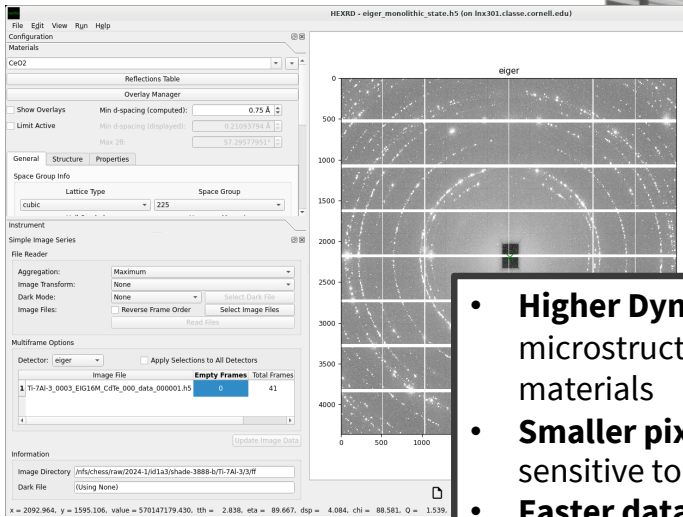
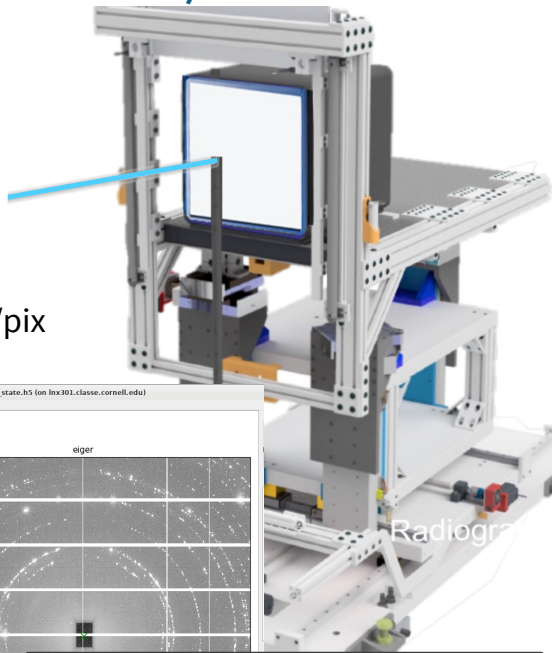
Detectors capture many in-plane strain components simultaneously

Measurement Needs Required State of the Art Detector Systems

Monochromatic (discrete 40-90keV)

**Dectris CdTe
Eiger2 X 16M**

Frame Rate: 200 Hz
Count Rate: 10^7 ph/sec/pix



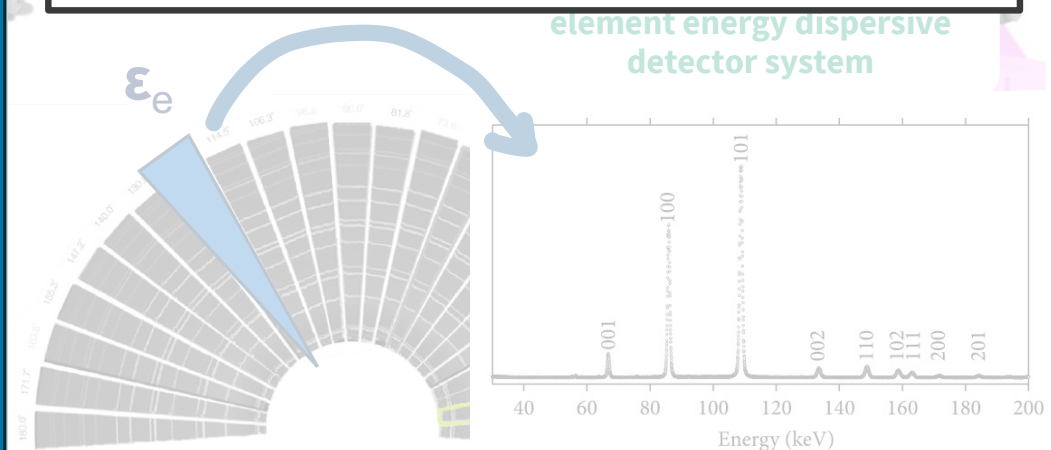
- **Higher Dynamic Range** –see microstructure in real materials
- **Smaller pixel size** - more sensitive to strains
- **Faster data collection times**

Polychromatic “white beam” (continuous 50-200 keV)

$$\lambda = \frac{hc}{E} = 2d \sin \theta$$

↑ Measure ↑ Solve ↑ Set

Especially relevant for **multi-phase materials** and **complex microstructures** (e.g. large and small crystals diffracting)



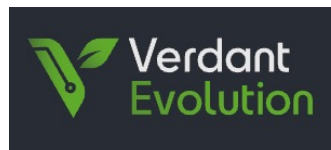
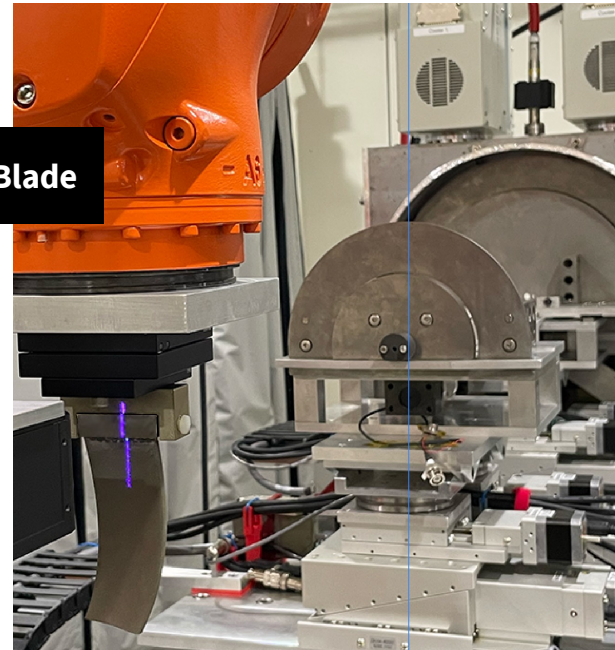
If you can't detect the signal - you can't perform the characterization

State of the Art Sample Manipulation

MSN-C program requires **evaluation of large parts with complex geometries** – sample positioning challenge



AM Ti Fan Blade



Integration of robotic arm into strain measurement workflow – robot path planning with laser-feedback

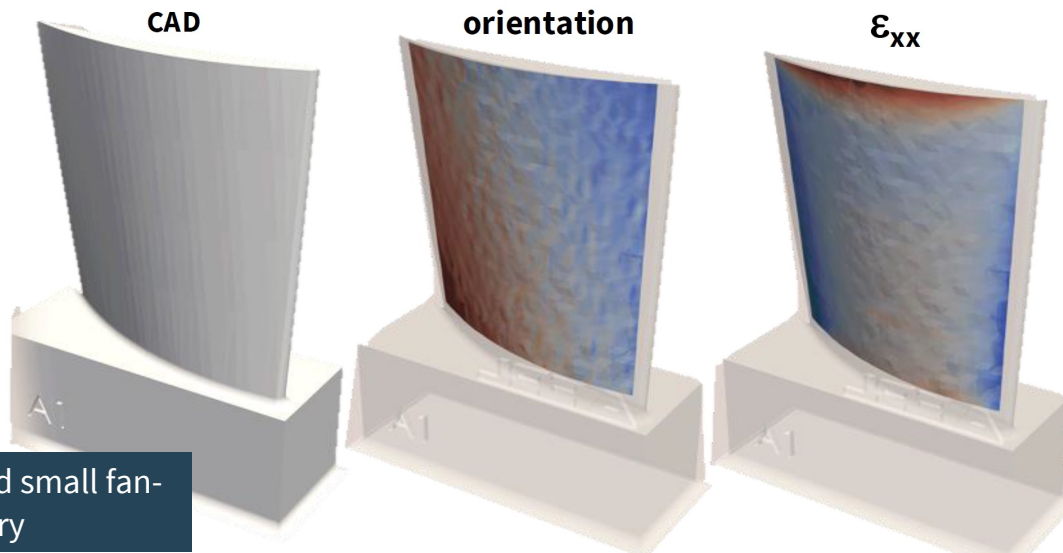
Laser Metrology

Complex parts **require digital twin** for planning and mapping

- CAD models do not always reflect the actual sample dimensions!

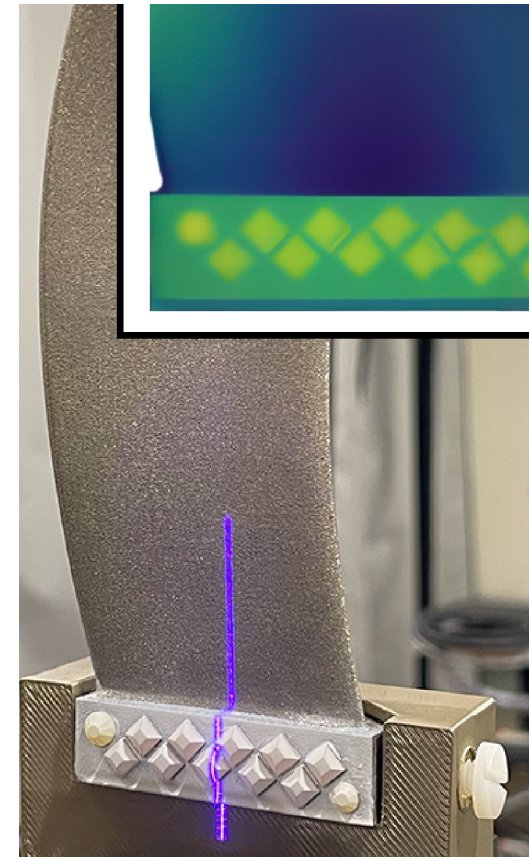


Additively Manufactured small fan-blade geometry



- Laser metrology facilitates evaluation of complex geometries
- Enables mapping in local coordinate system

Profiling Laser



Measurement Point Planner

Grid 2-Corner

Snap To Front Face:
 Align to Front Face:
 Align to Mid-Plane:
 Snap to Back Face:
 Fixed Depth (mm):
 Proximity Filter (mm):
 Min Depth Spacing (mm):

Margin:

X: Y: Z:

Dimensions:

X: Z:

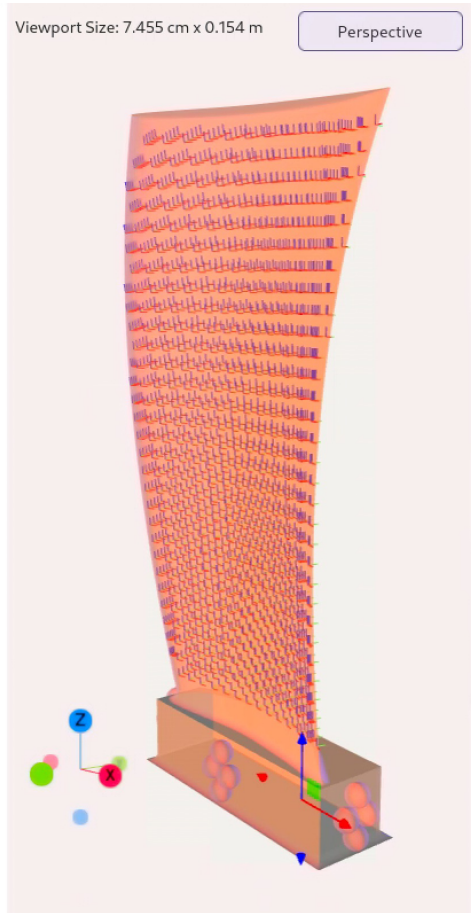
Number of Samples

X: Y: Z:

Transform

Units:

X: Roll:



Display

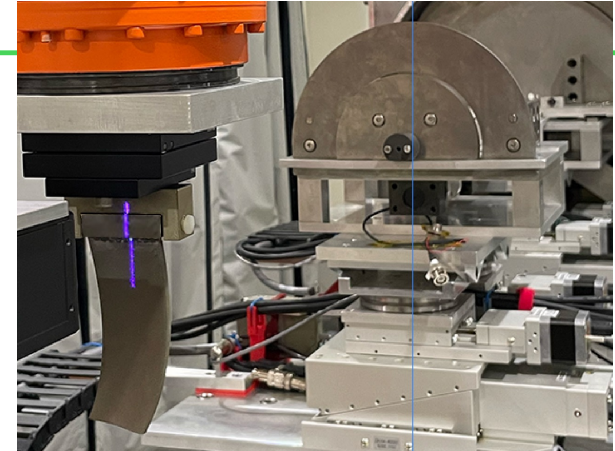
Show Local Axes:
 Show Beam Vectors:
 Show Strain Arc:
 Show Volume:

1 1 1

Runtime

Number of Points:
 Dwell Time (s):
 Estimated Time:

Grid 2-Corner X



- **Takes in CAD / Meshed samples or Point Clouds**
- **Pre-built patterns / grids**
 - Options to snap grid to faces or mid-planes planes of sample
 - Options to align orientation of point locally with respect to a surface normal
- **Import custom point patterns**
- **Calculate time based on number of points and dwell time**
- **Visualize points, diffraction volumes, beam vectors, and more**

Data Processing and Analysis Workflows

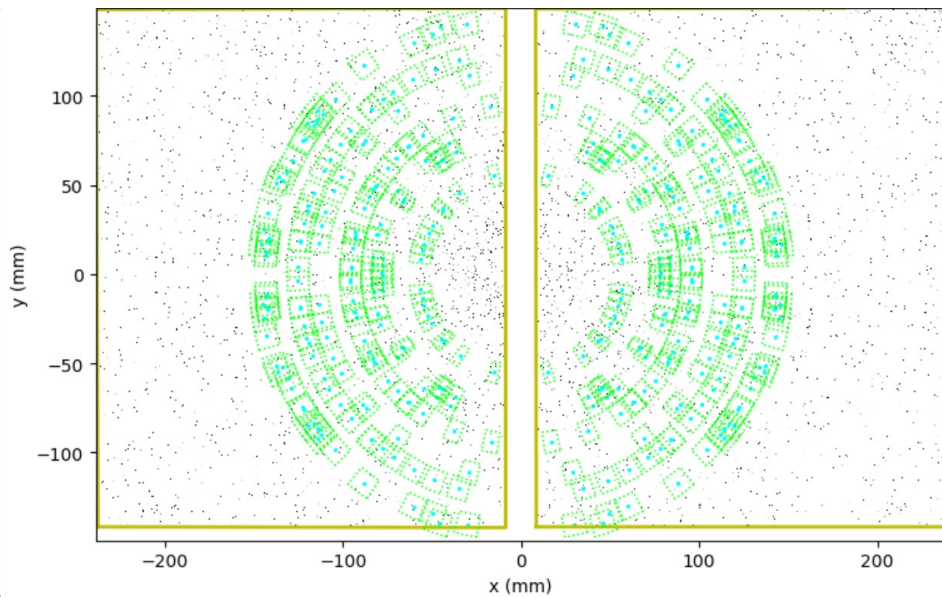


<https://hexrd.github.io>

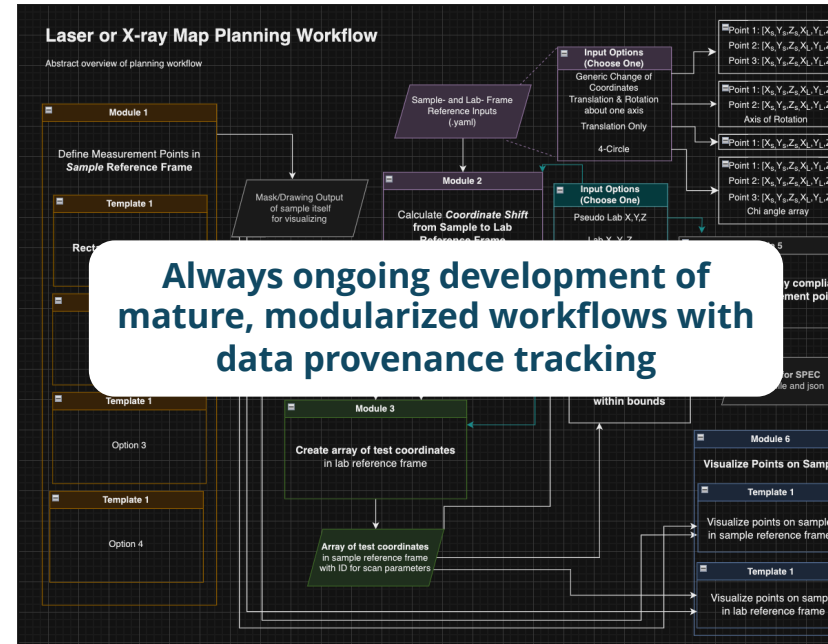
Highly Extensible X-ray Diffraction Toolkit (HEXRD)

Backbone of our analysis tools – especially for **highly sensitive elastic strain measurements**

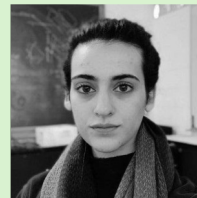
MSN-C and AFRL team core developers and contributors



HEXRD designed for ALL crystal structures – works for ceramics too!



Team of Talented Software Engineers



Keara Soloway



Rolf Verberg



Zack Singer



Kevin Welsh



Patrick Avery

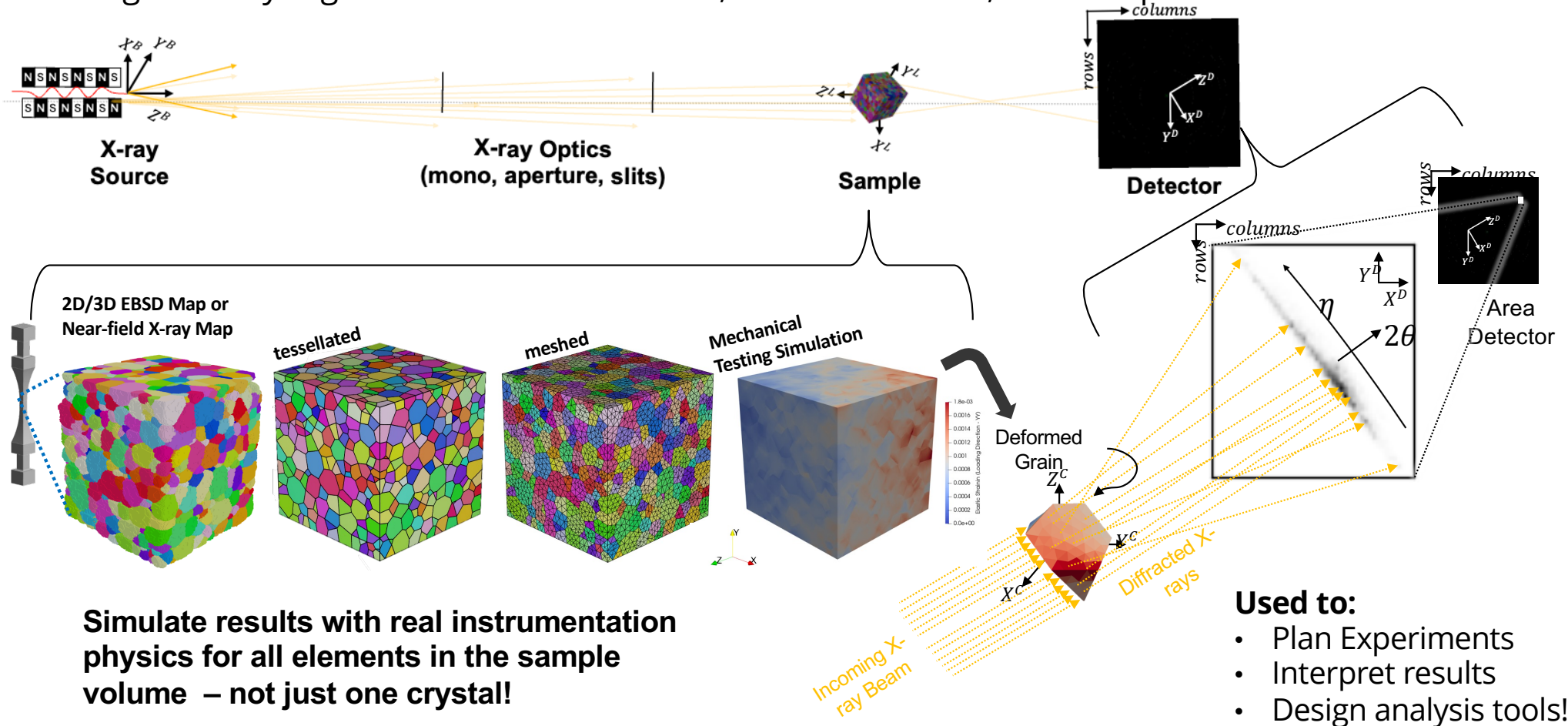
MSN-C

Verdant Evolution

Kitware, Inc

Mechanical Virtual Diffraction Experiment - MechVDE

High Fidelity Digital Twin of the Beamline, Instrumentation, and Sample

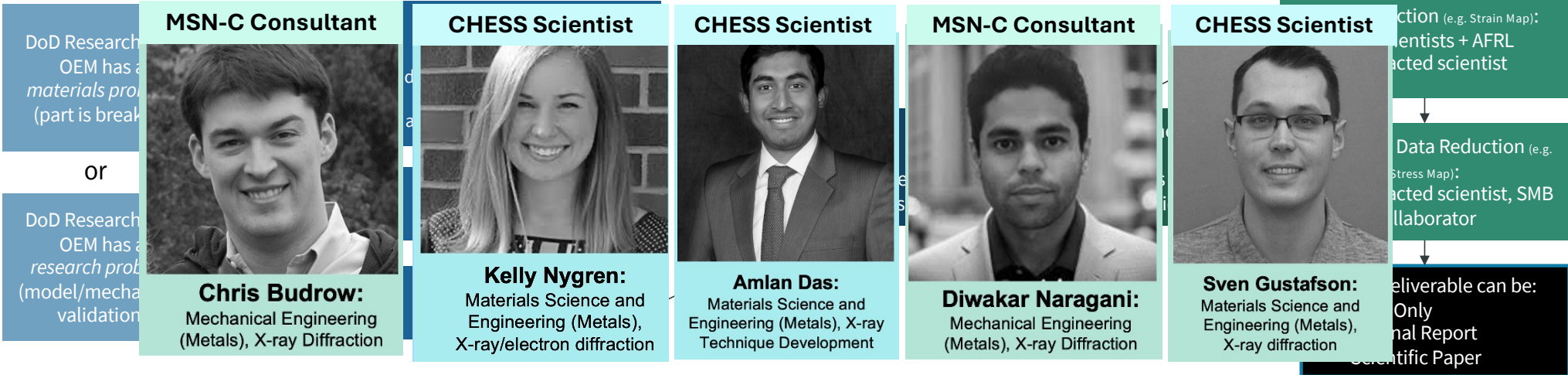


Simulate results with real instrumentation physics for all elements in the sample volume – not just one crystal!

Challenges informed SMB Structure & Access Model

***Start with a material problem –**
not an X-ray measurement

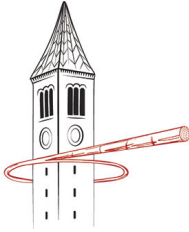
Deliver a reduced data product –
not raw X-ray data



Due to the nature of structural alloys each measurement campaign is unique

Better product when the X-ray campaign is designed by those who understand both the materials problem and the technique

CHESS
CORNELL HIGH ENERGY
SYNCHROTRON SOURCE



Structural Materials Beamline is part of the
Materials Solutions Network at CHESS
A defense sub-facility at CHESS (tri-service)



Unique mission, AFRL enhanced support, and beamtime allocation policy enabled development and maturation of transmission X-ray techniques and instrumentation for Defense needs



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